

General Description

The Sanrise SRC65R330B is a high voltage power MOSFET, fabricated using advanced super junction technology. The resulting device has extremely low on resistance, low gate charge and fast switching time, making it especially suitable for applications which require superior power density and outstanding efficiency.

The SRC65R330B break down voltage is 650V and it has a high rugged avalanche characteristics.

The SRC65R330B is available in TO-220F , TO-220C and TO-252 packages.

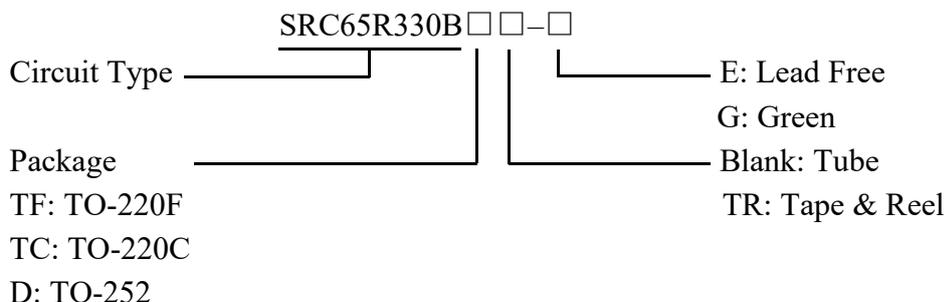
Features

- Ultra Low $R_{DS(ON)} = 330m\Omega @ V_{GS} = 10V$.
- Ultra Low Gate Charge, $Q_g = 25.8nC$ typ.
- Intrinsic Fast-Recovery Body Diode
- Fast switching capability
- Robust design with better EAS performance
- Non-automotive Qualified
- Ultra-fast body diode

Application

- PC Power
- Server / Telecom
- High Performance LED Lighting Power

Ordering Information



Package	Part Number	Marking ID	Packing Type
TO-220F	SRC65R330BTF-G	SRC65R330BTFG	Tube
TO-220C	SRC65R330BTC-G	SRC65R330BTCG	Tube
TO-252	SRC65R330BDTR-G	SRC65R330BDG	Tape & Reel

Symbol

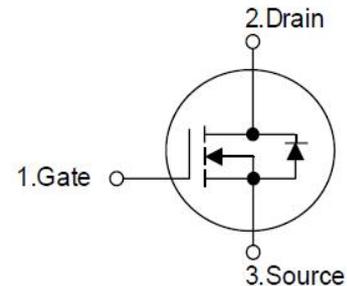


Figure 1 Symbol of SRC65R330B

Package Type

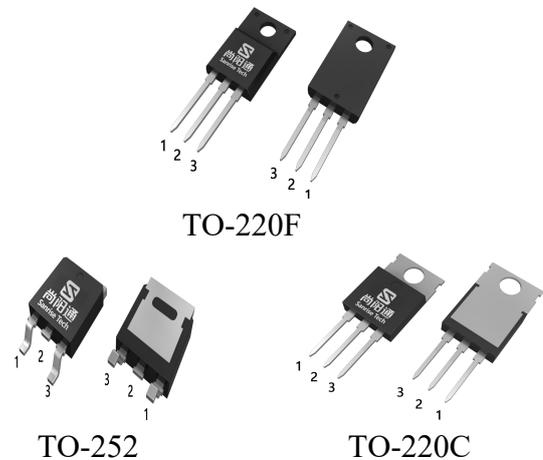


Figure 2 Package Types of SRC65R330B

Absolute Maximum Ratings

Parameter		Symbol	Rating	Unit
Drain-Source Voltage (Note2)		V_{DSS}	650	V
Gate-Source Voltage		V_{GSS}	±30	V
Gate-Source Voltage, AC ($f > 1$ Hz)		V_{GSS}	±30	V
Continuous Drain Current	$T_C = 25^\circ\text{C}$	I_D	12.0	A
	$T_C = 100^\circ\text{C}$		7.6	
	$T_C = 125^\circ\text{C}$		5.4	
Power Dissipation ($T_C = 25^\circ\text{C}, \text{TO-252}, \text{TO-220C}$)		P_{tot}	86	W
Power Dissipation ($T_C = 25^\circ\text{C}, \text{TO-220F}$)		P_{tot}	32	W
Pulsed Drain Current (Note 3)		I_{DM}	36	A
Avalanche Energy, Single Pulse (Note 4)		E_{AS}	185	mJ
Avalanche Energy, Repetitive (Note 3)		E_{AR}	0.2	mJ
Avalanche Current, Repetitive (Note 3)		I_{AR}	3.5	A
Continuous Diode Forward Current		I_S	12.0	A
Diode Pulse Current		$I_{S,PULSE}$	35	A
Operating Junction Temperature		T_J	150	$^\circ\text{C}$
Storage Temperature		T_{STG}	-55 to 150	$^\circ\text{C}$
Lead Temperature (Soldering, 10 sec)		T_{LEAD}	260	$^\circ\text{C}$

Note:

1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.
2. For voltage spike during switching.
3. Repetitive Rating: Pulse width limited by maximum junction temperature
4. $I_{AS} = 2\text{A}$, $V_{DD} = 60\text{V}$, $R_G = 25\Omega$, Starting $T_J = 25^\circ\text{C}$

Thermal Resistance

Parameter		Symbol	Min	Typ	Max	Unit
Thermal resistance, Junction-to-Case	TO-220F	R_{thJC}			3.85	$^\circ\text{C} / \text{W}$
	TO-252				1.44	
	TO-220C				1.44	
Thermal resistance, Junction-to-Ambient	TO-220F	R_{thJA}			70	$^\circ\text{C} / \text{W}$
	TO-252				62	
	TO-220C				62	

Electrical Characteristics

$T_J = 25^\circ\text{C}$, unless otherwise specified.

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Statistic Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	650			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=650V, V_{GS}=0V$			10	μA
Gate-Body Leakage Current	Forward	$I_{GSSF}, V_{GS}=30V, V_{DS}=0V$			100	nA
	Reverse	$I_{GSSR}, V_{GS}=-30V, V_{DS}=0V$			-100	
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	3.0	4.0	5.0	V
Static Drain-Source On-Resistance	$R_{DS(ON)}$	$V_{GS}=10V, I_D=5.0A$		250	330	$m\Omega$
Gate Resistance	R_G	$f=1MHz, \text{Open Drain}$		2.0		Ω
Dynamic Characteristics						
Input Capacitance	C_{ISS}	$V_{DS}=50V, V_{GS}=0V, f=1MHz$		1140		pF
Output Capacitance	C_{OSS}			74		
Reverse Transfer Capacitance	C_{RSS}			15		
Effective output capacitance, energy related ^{NOTE5}	$C_{O(er)}$	$V_{GS}=0V, V_{DS}=0\dots 480V$		47.0		pF
Effective output capacitance, time related ^{NOTE6}	$C_{O(tr)}$			201		
Turn-on Delay Time	$t_{d(on)}$	$V_{DD}=400V, I_D=5.5A, R_G=10\Omega, V_{GS}=10V$		12		ns
Rise Time	t_r			20		
Turn-off Delay Time	$t_{d(off)}$			24		
Fall Time	t_f			50		
Gate Charge Characteristics						
Gate to Source Charge	Q_{gs}	$V_{DD}=480V, I_D=5.5A, V_{GS}=0 \text{ to } 10V$		7.4		nC
Gate to Drain Charge	Q_{gd}			8.2		
Gate Charge Total	Q_g			25.8		
Gate Plateau Voltage	$V_{plateau}$			5.4		V
Reverse Diode Characteristics						
Drain-Source Diode Forward Voltage	V_{SD}	$V_{GS}=0V, I_{SD}=5.5A$		0.84	1.1	V
Reverse Recovery Time	t_{rr}	$V_R=400V, I_F=5.5A, dI_F/dt=100A/\mu s$		93		ns
Reverse Recovery Charge	Q_{rr}			0.33		μC
Peak Reverse Recovery Current	I_{rrm}			7.1		A

Note:

5. $C_{O(er)}$ is a fixed capacitance that gives the same stored energy as C_{OSS} while V_{DS} is rising from 0 to 480V

6. $C_{O(tr)}$ is a fixed capacitance that gives the same charging time as C_{OSS} while V_{DS} is rising from 0 to 480 V



Sanrise Technology Limited Company

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